

INFORMATION DISCLOSURE
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ATTY. DOCKET NO.

1035-240

APPLICANT

IZUMI et al

FILING DATE

December 13, 1999

SERIAL NO.

09/459,641

GROUP

2713

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>W</i>	5,319,206	6-1994	Lee et al.			
<i>W</i>	5,379,336	1-1995	Kramer et al.			

FOREIGN PATENT DOCUMENTS

DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>W</i>	5-72724 A	3-1993	JP		partial
	5-173320 A	7-1993	JP		partial
	6-342098 A	12-1994	JP		partial
	0 602 475 A2	6-1994	EP		
	0 523 783 A1	1-1993	EP		
<i>W</i>	0 783 177 A1	7-1997	EP		

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

<i>W</i>	Lee et al, "A New Digital Detector for Projection Radiography", SPIE, vol. 2432, July 1995, pp. 237-249
	Jeromin et al, "8.4: Application of a-Si Active-Matrix Technology in a X-Ray Detector Panel", SID 97 Digest, 1997, pp. 91-94
	Fujikura et al, "Design of Cushion Layer which Enables "TRANSFER" System to Laminate with High Speed", IDW '98, Proceedings of the Fifth International Display Workshops, Dec. 7-9, 1998, International Conference Center Kobe, Kobe, Japan, pp. 315-318
	Hunt et al, "Detective Quantum Efficiency of Direct, Flat Panel X-ray Imaging Detectors for Fluoroscopy", SPIE, vol. 3336, Medical Imaging 1998, Physics of Medical Imaging, February 1998, pp. 408-417
	Kinno et al, "Development of a Large Area Direct Conversion X-ray Image Detector", IDW '98, 1998, pp. 159-162
	den Boer et al, "25.1: Similarities Between TFT Arrays for Direct-Conversion X-Ray Sensors and High-Aperture AMLCDs, SID 98 Digest, 1998, pp. 371-374
	USSN 09/229,269, filed January 13, 1999, entitled "Two-Dimensional Image Detector and Process for Manufacturing the Same"
	USSN 09/239,855, filed January 29, 1999, entitled "Two-Dimensional Image Detecting Device and Manufacturing Method Thereof"
<i>W</i>	USSN 09/437,470, filed November 10, 1999, entitled "TWO-DIMENSIONAL IMAGE DETECTING DEVICE AND MANUFACTURING METHOD THEREOF"

*Examiner

Date Considered

9-22-03

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

Form PTO-FB-A820 (Also PTO-1449)